Applicant(s)/Patent Under Application/Control No. Reexamination 10/809,323 MITSUMOTO ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 Sin J. Lee 1752 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2002/0177074 11-2002 Hoshi et al. 430/281.1 Α * Yanaka et al. 430/138 US-2002/0102488 08-2002 В US-С US-D US-Ε US-F US-G US-Н US-1 US-J

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